

Optoelectronic Probing Solutions

- Manual, Semiautomatic & Fully Automatic Versions
 - Single-Sided or Double-Sided
- LEDS, Photodiodes, VCSELS, EELDS, Silicon Photonics
- Thermal Systems from -60 C to 300 C
- Customized Chucks and Carrier Plates
- Integrating Spheres or Fibers (single or multi-mode)
- Dark Boxes or Localized Environmental Chambers (LEC)
- Manipulators – manual, programmable and hexapods
- Non-Contact Height Measurement Sensors
- Probe Tips, Probe Cards, Wedges
- Integrated Solutions
- Modular PS4L Hardware & Software Architecture

